Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/701,824	CHANG ET AL.	
Examiner	Art Unit	
Hsien-ming Lee	2823	

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SEARCHED				
Class	Subclass	Date	Examiner	
438	14, 16	3/17/55	Lu	
257	48, 414		1	
257	618.			
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
257	48,414	9/1/25	Lu
257	618	1	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST attaCHED (USPAT, USPG, USOCR, EPO, JPO, IBM, Derwent)	3/17/2005	LEE
Ðì₩	8/25/05, 9/01/05	Lee
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